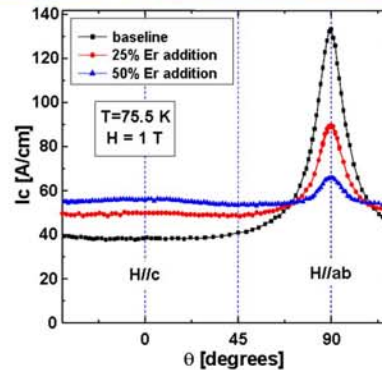


# Control of Flux Pinning in High Temperature Superconducting Tapes

Dean Miller<sup>a</sup>, Raul Arenal de la Concha<sup>a</sup>, Jon Hiller<sup>a</sup>, Ken Gray<sup>a</sup>, Vic Maroni<sup>b</sup>, Leonardo Civate<sup>c</sup>, Marty Rupich<sup>d</sup>  
<sup>a</sup> Materials Science Division, Argonne National Laboratory; <sup>b</sup> Chemical Engineering Division, Argonne National Laboratory; <sup>c</sup> Superconductivity Tech. Center, Los Alamos National Lab., <sup>d</sup> American Superconductor Corp.

## MOTIVATION

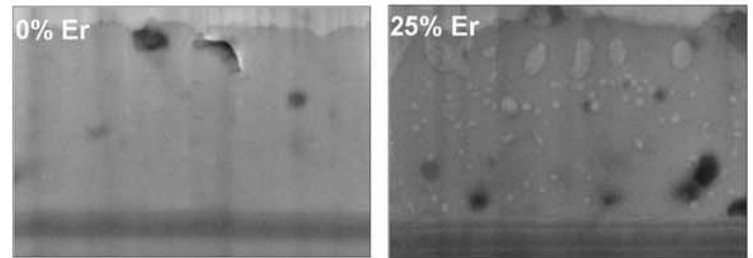
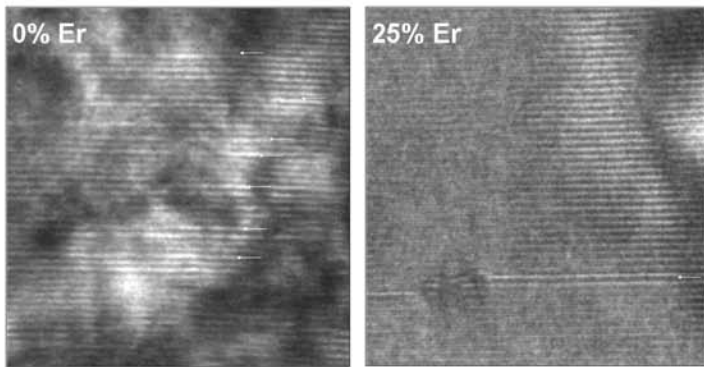
Improving the performance of  $\text{YBa}_2\text{Cu}_3\text{O}_x$  (YBCO) superconducting tapes in the presence of magnetic fields is one of the most significant challenges for their application in electric generation and distribution. We have learned how to improve in-field performance through manipulation of composition and processing, but the underlying mechanism that controls this behavior must be understood.



The critical current,  $I_c$ , as a function of field orientation can be manipulated through composition and processing.

## MAJOR ACCOMPLISHMENTS

We have elucidated the role of microstructural defects on in-field performance of these superconducting tapes. The variations in critical current as a function of field orientation can be explained based on the interplay between two types of defects.



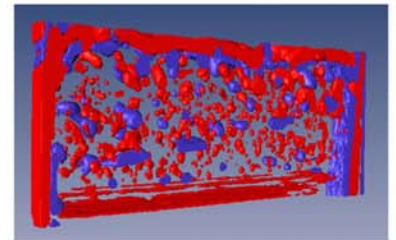
$(\text{Y,Er})_2\text{O}_3$  particles dominate for higher Er content and provide strong pinning and high  $I_c$  for H//c

TEM

## FUTURE DIRECTIONS

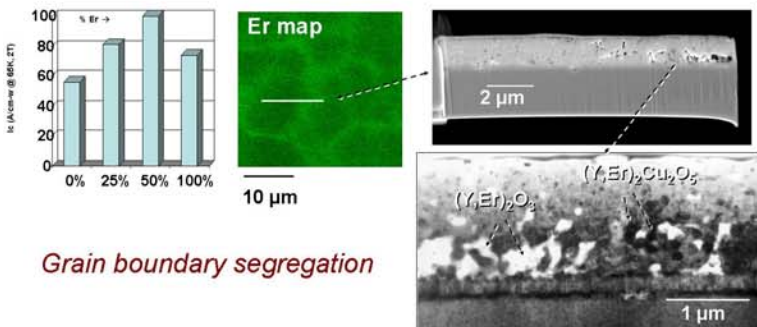
Understanding how defects control performance in the superconducting tapes suggests that if we learn how to control those defects, we can manipulate properties more effectively. Can we achieve both planar defects *and* small particles at the same time?

3-D microstructure reconstruction provides an excellent pathway to identify the phase assemblage and quantify distribution.



We will couple analysis of partially converted tapes with thermodynamic phase analysis to identify the key constituents that lead to defect formation. The decrease in planar defect density with increasing Er addition suggests a change in phase assemblage.

Why not add more Er to improve  $I_c$  for H//c further??



Grain boundary segregation

"Coordinated Characterization of Coated Conductors," V.A. Maroni, D.J. Miller, S. Trasobares, Y. Lei, J.M. Hiller, K.E. Gray, V.K. Vlasko-Vlasov, H. Claus, J. Reeves, M. Rupich, W. Zhang, T. Kodanandath, X. Li, IEEE Trans. Supercon. 15 (2): 2798-2802 (Jun. 2005)